

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/821,736 TAKEUCHI ET AL.	
		Examiner	Art Unit MARK J. BEAUCHAINE	3653 Page 1 of 1

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*	B	US-6,874,682	04-2005	Utz et al.	235/379
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